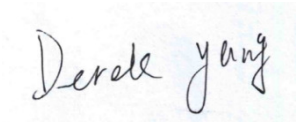
FCC TEST REPORT

Application No.:	HR/2020/B0007
Applicant:	Honor Device Co., Ltd.
Address of Applicant	Suite 3401, Unit A, Building 6, Shum Yip Sky Park, No. 8089, Hongli West Road, Xiangmihu Street, Futian District, Shenzhen, Guangdong 518040, People's Republic of China
Manufacturer:	Honor Device Co., Ltd.
Address of Manufacturer	Suite 3401, Unit A, Building 6, Shum Yip Sky Park, No. 8089, Hongli West Road, Xiangmihu Street, Futian District, Shenzhen, Guangdong 518040, People's Republic of China
EUT Description:	Smart Phone
Model No.:	CHL-LX1
Trade Mark:	HONOR
FCC ID:	2AYGCCHL-LX1
Standards:	47 CFR Part 2 47 CFR Part 22 subpart H 47 CFR Part 24 subpart E 47 CFR Part 27 subpart C
Test Method:	FCC KDB 971168 D01 Power Meas License Digital Systems V03r01 C63.26 (2015)
Date of Receipt:	2020/12/9
Date of Test:	2020/12/9 to 2020/12/31
Date of Issue:	2020/12/31
Test Result :	**PASS ***

* In the configuration tested, the EUT detailed in this report complied with the standards specified above.

Authorized Signature:



Derek Yang
Wireless Laboratory Manager

1 Version

Revision Record				
Version	**Chapter**	**Date**	**Modifier**	**Remark**
01		2020-12-31		Original

Authorized for issue by:				
Tested By		Mike Hu **(Mike Hu) /Project Engineer**		
Checked By		David Chen **(David Chen) /Reviewer**		

Contents

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2 Test Summary

2.1 GSM850/UMTS Band 5

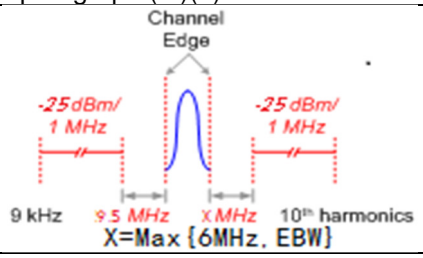
Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §22.913	FCC: ERP ≤ 7 W	Section 1 of Appendix B	Pass
Peak-Average Ratio	---	Limit≤13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §22.917	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, §22.917	FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §22.917	FCC: ≤ -13 dBm/100 kHz.	Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §22.355	≤ ±2.5ppm.	Section 8 of Appendix B	Pass
Remark: For the verdict, the “N/A” denotes “not applicable”, the “N/T” denotes “not tested”.				

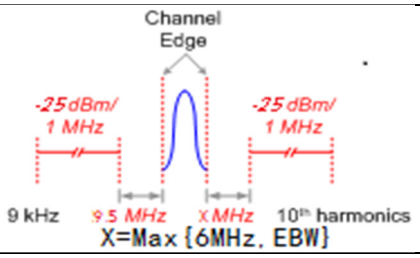
2.2 GSM 1900/UMTS Band 2

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §24.232	EIRP ≤ 2 W	Section 1 of Appendix B	Pass
Peak-Average Ratio	§2.1046, §24.232	Limit≤13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §24.238	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B	Pass

Spurious Emission at Antenna Terminals	§2.1051, §24.238	≤ -13 dBm/1 MHz, from 9 kHz to 10th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §24.238	≤ -13 dBm/1 MHz.	Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §24.235	≤ ±2.5 ppm.	Section 8 of Appendix B	Pass
Remark: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".				

2.3 LTE Band 7

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(h)	EIRP ≤ 2W	Section 1 of Appendix B	Pass
Peak-Average Ratio	§27.50(a)	≤13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §27.53(m4)	For mobile digital stations, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section.	Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)		Section 6 of Appendix B	Pass

Field Strength of Spurious Radiation	§2.1053, §27.53(m)		Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §27.54	Within authorized bands of operation/frequency block.	Section 8 of Appendix B	Pass
Remark: For the verdict, the “N/A” denotes “not applicable”, the “N/T” denotes “not tested”.				

3 General Information

3.1 Details of Client

Applicant:	Honor Device Co., Ltd.
Address of Applicant	Suite 3401, Unit A, Building 6, Shum Yip Sky Park, No. 8089, Hongli West Road, Xiangmihu Street, Futian District, Shenzhen, Guangdong 518040, People's Republic of China
Manufacturer:	Honor Device Co., Ltd.
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3.2 Test Location

Company:	SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch
Address:	No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China
Post code:	518057

3.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• **CNAS (No. CNAS L2929)**

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2017 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

• **A2LA (Certificate No. 3816.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

• **VCCI**

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

• **FCC –Designation Number: CN1178**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.
Designation Number: CN1178. Test Firm Registration Number: 406779.

• **Industry Canada (IC)**

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

3.4 General Description of EUT

EUT Description:	Smart Phone
Model No.:	CHL-LX1
Trade Mark:	HONOR
Hardware Version:	HL3CHLM
Software Version:	5.0.1.69(C900E12R1P2)
Sample Type:	☒ Portable Device, ☐Module
Antenna Type:	☐ External, ☒ Integrated
Antenna Gain:	GSM850: -1.6dBi(Down Antenna); -1.4dBi(UP ANTENNA); GSM1900:-3.5dBi(DOWN ANTENNA); -2.6dBi(UP ANTENNA); WCDMA Band II:-3.5dBi(DOWN ANTENNA); -2.6dBi(UP ANTENNA); WCDMA Band V:-1.6dBi(DOWN ANTENNA); -1.4dBi(UP ANTENNA); LTE Band 7: -1.4dBi(DOWN ANTENNA); -1.5dBi(UP ANTENNA);

3.5 Test Mode

Test Mode	Test Modes Description
GSM/TM1	GSM system, GSM/GPRS, GMSK modulation
GSM/TM2	GSM system, EGPRS, 8PSK modulation
UMTS/TM1	UMTS system, WCDMA, QPSK modulation
LTE/TM1	LTE system, QPSK modulation
LTE/TM2	LTE system, 16QAM modulation
LTE/TM3	LTE system, 64QAM modulation

Remark: The test mode(s) are selected according to relevant radio technology specifications.

3.6 Test Environment

Operating Environment:		
Humidity:	50 % RH	
Atmospheric Pressure:	101.30 KPa	
Temperature	NT	25 ℃
Voltage:	LV	3.6V
	NV	3.87V
	HV	4.45V

Remark: LV= lower extreme test voltage; NV= nominal voltage
HV= upper extreme test voltage; NT= normal temperature

3.7 Technical Specification

Characteristics	Description		
Radio System Type	☒ GSM		
	☒ UMTS		
	☒ LTE		
Supported Frequency Range	Band	TX	RX
	GSM850	824 to 849 MHz	869 to 894 MHz
	GSM1900	1850 to 1910 MHz	1930 to 1990 MHz
	UMTS Band II	1850 to 1910 MHz	1930 to 1990 MHz
	UMTS Band V	824 to 849 MHz	869 to 894 MHz
	LTE Band 7	2500 to 2570 MHz	2620 to 2690 MHz
Target TX Output Power	GSM850:33.4dBm GSM1900: 30dBm UMTS Band II: 24dBm UMTS Band V: 25dBm LTE Band 7: 25dBm		
Supported Channel Bandwidth	GSM system:	☒0.2 MHz	
	UMTS system:	☒5 MHz	
	LTE Band 7	☒5 MHz; ☒10 MHz; ☒15 MHz, ☒ 20 MHz	

Characteristics	Description	
Designation of Emissions (Remark: the necessary bandwidth of which is the worst value from the measured occupied bandwidths for each type of channel bandwidth configuration.)	GSM850	248KGXW; 249KG7W
	GSM1900	248KGXW; 251KG7W
	UMTS Band II	4M19F9W;
	UMTS Band V	4M19F9W;
	LTE Band 7	4M48G7D;4M48W7D; 4M48W7D 8M95G7D;8M93W7D; 8M95W7D 13M5G7D;13M5W7D; 13M5W7D 17M9G7D;17M9W7D; 17M9W7D

3.8 Test Frequencies

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
GSM850	TX	Channel 128	Channel 190	Channel 251
		824.2MHz	836.6 MHz	848.8 MHz
	RX	Channel 128	Channel 190	Channel 251
		869.2 MHz	881.6 MHz	893.8 MHz

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
GSM1900	TX	Channel 512	Channel 661	Channel 810
		1850.2MHz	1880.0 MHz	1909.8 MHz
	RX	Channel 512	Channel 661	Channel 810
		1930.2 MHz	1960.0 MHz	1989.8 MHz

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
WCDMA Band II	TX	Channel 9262	Channel 9400	Channel 9538
		1852.4 MHz	1880.0 MHz	1907.6 MHz
	RX	Channel 9662	Channel 9800	Channel 9938
		1932.4 MHz	1960.0 MHz	1987.6 MHz

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
WCDMA Band V	TX	Channel 4132	Channel 4182	Channel 4233
		826.4MHz	836.4 MHz	846.6 MHz
	RX	Channel 4357	Channel 4407	Channel 4458
		871.4 MHz	881.4 MHz	891.6 MHz

Test Mode	Bandwidth	TX / RX	RF Channel		
			Low (L)	Middle (M)	High (H)
LTE Band 7	5MHz	TX	Channel 20775	Channel 21100	Channel 21425
			2502.5 MHz	2535 MHz	2567.5 MHz
		RX	Channel 2775	Channel 3100	Channel 5825
			2622.5 MHz	2655 MHz	2687.5 MHz
	10MHz	TX	Channel 20800	Channel 21100	Channel 21400
			2505 MHz	2535 MHz	2565 MHz
		RX	Channel 2800	Channel 3100	Channel 3400
			2625 MHz	2655 MHz	2685 MHz
	15MHz	TX	Channel 20825	Channel 21100	Channel 21375
			2507.5 MHz	2535 MHz	2562.5 MHz
		RX	Channel 2825	Channel 3100	Channel 3375
			2627.5 MHz	2655 MHz	2682.5 MHz
	20MHz	TX	Channel 20850	Channel 21100	Channel 21350
			2510 MHz	2535 MHz	2560 MHz
		RX	Channel 2850	Channel 3100	Channel 3350
			2630 MHz	2655 MHz	2680 MHz

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4 Description of Tests

4.1 Conducted Output Power

Measurement Procedure:

1: The testing follows FCC KDB 971168 D01 V03r01 ; ANSI C63.26 Section 5.2

2: The transmitter output port was connected to the System simulator with a Calibrated RF cable.

3: Set EUT at maximum power through the system simulator.

4: The power output at the transmitter antenna port was determined by adding the value of the cable insertion loss to the power reading.

5: The tests were performed at three frequencies (low channel, middle channel and high channel) for each band and different modulation,and on the highest power levels.

6: Record the power from the system simulator.

Remark: Reference test setup 1

4.2 Effective (Isotropic) Radiated Power of Transmitter

Effective (Isotropic) Radiated Power is calculated by adding highest antenna gain to maximum measured conducted output power in dBm by the following formula:

ERP (dBm) = Conducted Power (dBm) + antenna gain (dBd)

EIRP(dBm) = Conducted Power (dBm) + antenna gain (dBi)

EIRP=ERP+2.15dB

4.3 Occupied Bandwidth

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 4.2

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel, middle channel and high channel).The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Remark: Reference test setup 1

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Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5% of the expected OBW
3. VBW ≥ 3 x RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5% of the 99% occupied bandwidth observed in Step 7

4.4 Band Edge at Antenna Terminals

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at two frequencies (low channel and high channel).in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to rms.

Remark: Reference test setup 1

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW ≥ 1% of the emission bandwidth
4. VBW ≥ 3 x RBW
5. Detector = RMS
6. Number of sweep points ≥ 2 x Span/RBW
7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
8. Sweep time = auto couple
9. The trace was allowed to stabilize

4.5 Spurious And Harmonic Emissions at Antenna Terminal

Measurement Procedure: FCC KDB 971168 D01 V03r01

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel).The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Remark: Reference test setup 1

Test Settings

1. Start frequency was set to 30MHz and stop frequency was set to at least 10 * the fundamental frequency (separated into at least two plots per channel)
2. Detector = RMS
3. Trace mode = trace average for continuous emissions, max hold for pulse emissions
4. Sweep time = auto couple
5. The trace was allowed to stabilize
6. Please see test notes below for RBW and VBW settings

4.6 Peak-Average Ratio

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.7.1

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Remark: Reference test setup 1

Test Settings

1. The signal analyzer's CCDF measurement profile is enabled
2. Frequency = carrier center frequency
3. Measurement BW > Emission bandwidth of signal
4. The signal analyzer was set to collect one million samples to generate the CCDF curve
5. The measurement interval was set depending on the type of signal analyzed. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power

4.7 Field Strength of Spurious Radiation

Measurement Procedure: FCC KDB 971168 D01 V03r01

Below 1GHz test procedure as below:

1). The EUT was powered ON and placed on a 80cm high table in the chamber. The antenna of the transmitter was extended to its maximum length.

2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.

3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.

4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.

5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.

6). The output power into the substitution antenna was then measured.

7). Steps 5) and 6) were repeated with both antennas polarized.

8) Calculate power in dBm by the following formula:

ERP(dBm) = Pg(dBm) – cable loss (dB) + antenna gain (dBd)

Where:

Pd is the dipole equivalent power, Pg is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB]. The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log10(Power [Watts]).

Above 1GHz test procedure as below:

1) Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber

2) Calculate power in dBm by the following formula:
EIRP(dBm) = Pg(dBm) – cable loss (dB) + antenna gain (dBi)
EIRP=ERP+2.15dB
Where:
Pg is the generator output power into the substitution antenna.
3. Test the EUT in the lowest channel, the middle channel the Highest channel
4. The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
5. Repeat above procedures until all frequencies measured was complete

Remark1: Reference test setup 2

Remark2: The emission below 18G were measured at a 3m test distance, while emissions above 18GHz were measured at a 1m test distance.

Test Settings:

1. RBW=100kHz for emission below 1GHz and 1MHz for emission above 1GHz
2. VBW≥3*RBW
3. Number of sweep point≥2*span/RBW
4. Detector=RMS
5. Trace mode=Average (Max Hold for pulsed emissions)
6. The trace was allowed to stabilize

4.8 Frequency Stability / Temperature Variation

Measurement Procedure:
Frequency stability testing is performed in accordance with the guidelines of FCC KDB 971168 D01 V03r01; ANSI/C63.26 (2015)
. The frequency stability of the transmitter is measured by:
a.) **Temperature:** The temperature is varied from -30℃ to +50℃ in 10℃ increments using an environmental chamber.
b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.
Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within ±0.00025% (±2.5 ppm) of the center frequency.

Time Period and Procedure:
1. The carrier frequency of the transmitter is measured at room temperature (20℃ to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after

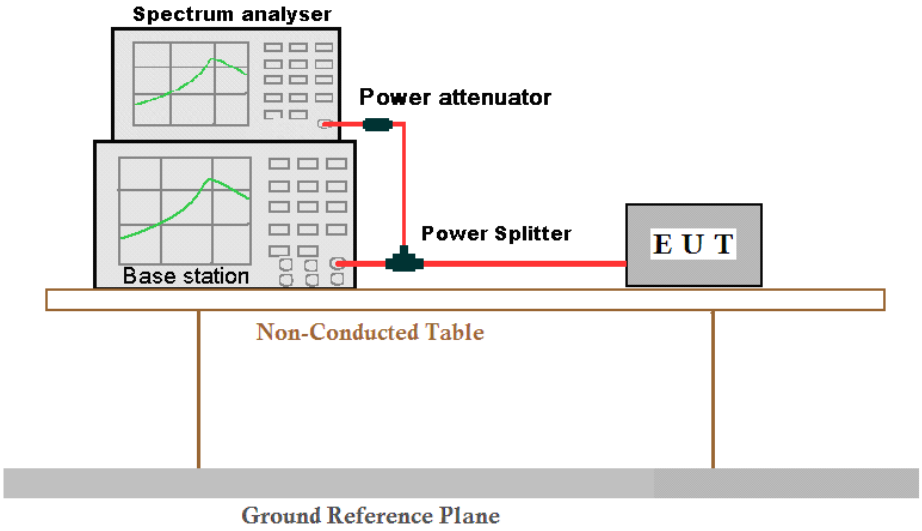
applying power to the transmitter.

3. Frequency measurements are made at 10℃ intervals ranging from -30℃ to +50℃. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Remark: Reference test setup 3

4.9 Test Setups

4.9.1 Test Setup 1



4.9.2 Test Setup 2

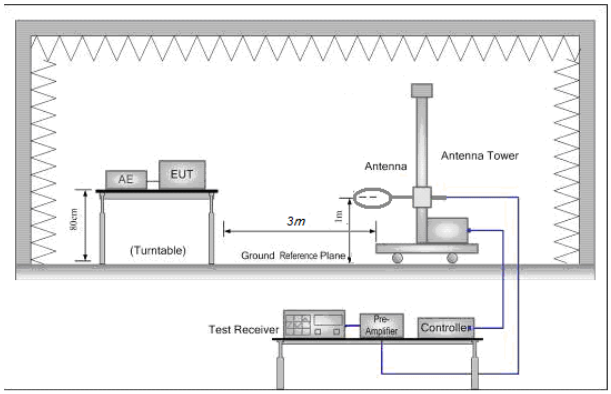


Figure 1. Below 30MHz

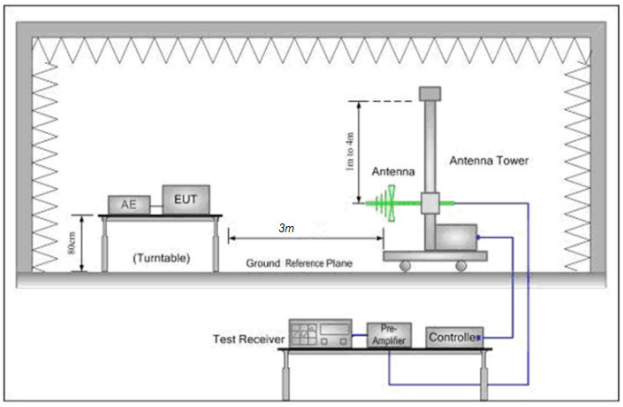


Figure 2. 30MHz to 1GHz

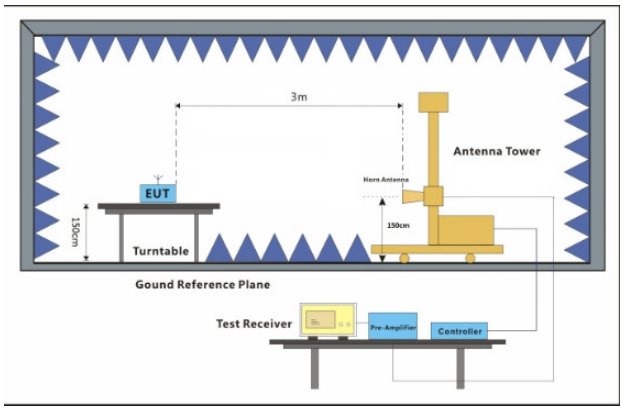
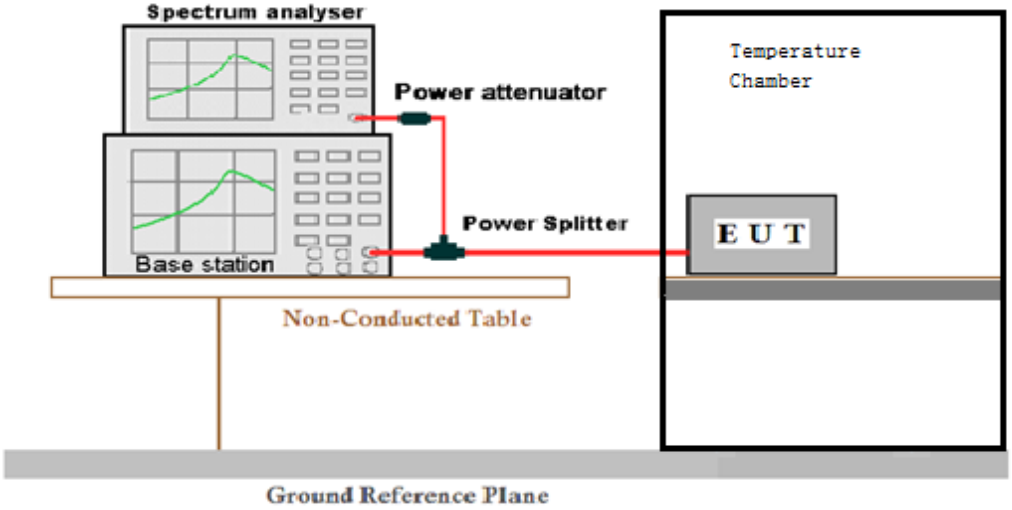


Figure 3. above 1GHz

4.9.3 Test Setup 3



4.10 Test Conditions

Test Case		Test Conditions	
Transmit Output Power Data	Average Power, Total	Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2; LTE/TM3;

	Average Power, Spectral Density (if required)	Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2; LTE/TM3;
Peak-to-Average Ratio (if required)		Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2; LTE/TM3;
Modulation Characteristics		Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	M (M= middle channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2; LTE/TM3;
Bandwidth	Occupied Bandwidth	Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2; LTE/TM3;
	Emission Bandwid	Test Environment	Ambient Climate & Rated Voltage

	th (if required)	Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2; LTE/TM3;
Band Edges Compliance		Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, H (L= low channel, H= high channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2; LTE/TM3;
Spurious Emission at Antenna Terminals		Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L,M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1; GSM/TM2;UMTS/TM1; LTE/TM1; LTE/TM2; LTE/TM3;
Field Strength of Spurious Radiation		Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 2
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1; LTE/TM2; LTE/TM3; Remark: If applicable, the EUT conf. that has maximum power density (based on the equivalent power level) is selected.
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Frequency Stability		Test Environment	(1) -30 ℃ to +50 ℃ with step 10 ℃ at Rated Voltage; (2) VL, VN and VH of Rated Voltage at Ambient Climate.
		Test	Test Setup 3

	Setup	
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2 ;LTE/TM3;

5 Main Test Instruments

RE in Chamber					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
3m Semi-Anechoic Chamber	AUDIX	N/A	SEM001-02	2018/3/13	2021/3/12
Spectrum Analyzer (20Hz-43GHz)	Rohde & Schwarz	FSU43	SEM004-08	2020/4/16	2021/4/15
BiConiLog Antenna (26-3000MHz)	ETS-Lindgren	3142C	SEM003-01	2020/6/12	2023/6/11
Horn Antenna (800MHz-18GHz)	Rohde & Schwarz	HF907	SEM003-07	2018/4/13	2021/412
Horn Antenna (15-40GHz)	Schwarzbeck	BBHA 9170	SEM003-15	2020/10/17	2023/10/16
Amplifier (0.1-1300MHz)	HP	8447D	SEM005-02	2020/7/14	2021/7/14
Low Noise Amplifier (100MHz-18GHz)	Black Diamond Series	BDLNA-0118-352810	SEM005-05	2020/7/14	2021/7/14
Pre-Amplifier (0.1-26.5GHz)	Compliance Directions Systems Inc.	PAP-0126	EMC2063	2020/9/20	2021/9/19
Pre-amplifier (26-40GHz)	Compliance Directions Systems Inc.	PAP-2640-50	SEM005-08	2020/4/16	2021/4/15
Band filter	N/A	N/A	N/A	N/A	N/A
Measurement Software	AUDIX	e3 V8.2014-6-27	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM026-01	2020/6/12	2021/6/11
Wideband Radio CommunicationTeste	Anristu	MT8821C	6201462742	2020/4/16	2021/4/15
Wideband Radio CommunicationTester	Rohde & Schwarz	CMW500	W005-02	2020/1/13	2021/1/2
Loop Antenna	ETS-Lindgren	6502	SEM003-08	2020-08-14	2023-08-13

RF conducted test					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
Dual Output Mobile Communication DC Source	Agilent Technologies Inc	66311B	W009-09	2020/10/22	2021/10/21
Signal Analyzer	Rohde & Schwarz	FSV	W005-02	2020/4/16	2021/4/15
Coaxial Cable	SGS	N/A	SEM031-01	2020/6/12	2021/6/11
Attenuator	Weinschel Associates	WA41	SEM021-09	N/A	N/A
Signal Generator	KEYSIGHT	N5173B	SEM006-05	2020/10/22	2021/10/21
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	HTC-1	W006-17	2020/10/22	2021/10/21
Temperature Chamber	GIANT FORCE	ICT-150-40-CP-AR	W027-03	2020/10/22	2021/10/21
Wideband Radio CommunicationTeste	Anristu	MT8821C	6201462742	2020/4/16	2021/4/15
Wideband Radio CommunicationTester	Rohde & Schwarz	CMW500	W005-02	2020/10/22	2021/10/21

Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. Date (yyyy-mm-dd)	Cal. Due date (yyyy-mm-dd)
3m Semi-Anechoic Chamber	AUDIX	N/A	SEM001-02	2018/3/13	2021/3/12
Wideband Radio CommunicationTeste	Anristu	MT8821C	6201462742	2020/4/16	2021/4/15
Wideband Radio CommunicationTester	Rohde & Schwarz	CMW500	W005-02	2020/1/3	2021/1/2
EXA Signal Analyzer (10Hz-26.5GHz)	Agilent Technologies Inc	N9010A	SEM004-09	2020/3/13	2021/3/12
Spectrum Analyzer (20Hz-43GHz)	Rohde & Schwarz	FSU43	SEM004-08	2020/4/16	2021/4/15
BiConiLog Antenna (26-3000MHz)	ETS-Lindgren	3142C	SEM003-01	2020/6/27	2023/6/26
Horn Antenna (800MHz-18GHz)	Rohde & Schwarz	HF907	SEM003-07	2018/4/13	2021/4/12
Horn Antenna (15-40GHz)	Schwarzbeck	BBHA 9170	SEM003-15	2020/10/17	2023/10/16
Amplifier (0.1-1300MHz)	HP	8447D	SEM005-02	2020/7/25	2021/7/24
Pre-Amplifier (0.1-26.5GHz)	Compliance Directions Systems Inc.	PAP-0126	SEM004-11	2020/7/25	2021/7/24
Pre-amplifier (26-40GHz)	Compliance Directions Systems Inc.	PAP-2640-50	SEM005-08	2020/4/16	2021/4/15
Band filter	N/A	N/A	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM026-01	2020/6/12	2021/6/11
Tunable Notch Filter WRCD1700/2000-0.2/40-10EEK	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
Tunable Notch Filter WRCD800/960-0.2/40-10EEK	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
HighPass Filter WHK1.2/15G-10SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
HighPass Filter WHKX10-2700-3000-18000-40SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
HighPass Filter WHKX7.0/26.5G-6SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A

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Band Reject Filter WRCG 824/849-814/859-40/8SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
Band Reject Filter WRCG 1850/1910-1835/1925-40/8SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
Measurement Software	AUDIX	e3 V8.2014-6-27	N/A	N/A	N/A

6 Measurement Uncertainty

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item	Extended Uncertainty	Data
Transmit Output Power Data	Power [dBm]	U =±0.37 dB
Bandwidth	Magnitude [%]	U =± 0.2%
Band Edge Compliance	Disturbance Power [dBm]	U = ±2.0 dB
Spurious Emissions, Conducted	Disturbance Power [dBm]	U = ±2.0 dB
Field Strength of Spurious Radiation	ERP[dBm]/EIRP [dBm]	For 3 m Chamber: U = ±4.5 dB (below 1GHz) U = ±3.3 dB (above 1GHz) For 10 m Chamber: U = ±4.5 dB (below 1GHz) U = ±3.2 dB (above 1GHz)
Frequency Stability	Frequency Accuracy [ppm]	U = ±0.24 ppm

7 Appendixes

Appendix A	Photographs of Set-Up for HR2020B0007
Appendix B.1	GSM
Appendix B.2	WCDMA
Appendix B.3	LTE Band 7

The End

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